Strain and correlation of self-organized Ge$_{1-x}$Mn$_x$ nanocolumns embedded in Ge (001)


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We report on the structural properties of Ge$_{1-x}$Mn$_x$ layers grown by molecular-beam epitaxy. In these layers, nanocolumns with a high Mn content are embedded in an almost-pure Ge matrix. We have used grazing-incidence x-ray scattering, atomic force and transmission electron microscopy to study the structural properties of the columns. We demonstrate how the elastic deformation of the matrix (as calculated using atomistic simulations) around the columns, as well as the average intercolumn distance can account for the shape of the diffusion around Bragg peaks.

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I. INTRODUCTION

Ferromagnetic semiconductors have been extensively studied over the last decade as they are considered as the material solution for the needs of the spin-based electronics. Among the possible candidate systems, germanium-based ones have the advantage of being compatible with existing main-stream silicon technology. In particular, early results on the control of the ferromagnetism ordering in gated germanium-manganese structures using an electric field have spurred many studies, focusing either on the diluted or the heterogeneous aspects of the GeMn system. Considering epitaxially grown GeMn systems, several groups have observed the self-assembly of Mn-rich, columnar-like nano-objects embedded in a Ge matrix. Curie temperatures above room temperature have been observed by Jamet et al. in these nanocolumns, and also more recently by Cho et al. in GeMn nanowires, by Zeng et al. in homogeneous Mn-doped Ge thin films with $x_{Mn} = 0.25\%$, and by Xiu et al. in Mn$_{0.05}$Ge$_{0.95}$ quantum dots, thus reinforcing the interest in this system.

The low-temperature molecular-beam epitaxy of Ge and Mn allows for a high concentration of Mn (up to 10\%) to be incorporated in the Ge matrix. Due to a spinodal decomposition occurring at the early stages of the growth, Mn-rich regions form. Depending on the growth parameters (substrate temperature, growth rate, manganese concentration), these inclusions can be spherical, cigar shaped, or columnar and extending throughout the GeMn layer. If the growth is performed at higher temperature or if the film is annealed, more stable phases can be seen, such as Mn$_2$Ge$_2$, Mn$_5$Ge$_3$, or Mn$_{11}$Ge$_8$ cluster. Many studies have shed light on the magnetic and electronic properties of the GeMn nanocolumns and inclusions. In terms of structural properties, the relationship between the GeMn layer and the Mn$_2$Ge$_3$ clusters is now well known. Although information about the local environment around Mn atoms has already been reported, the understanding of the structural properties of continuous GeMn nanocolumns and their surrounding matrix is not complete.

In this work we report on the strain and correlations of GeMn nanocolumns embedded in a Ge matrix, as determined by grazing-incidence x-ray scattering (GIXS) techniques at the European Synchrotron Radiation Facility (ESRF), as well as elastic and atomistic simulations. While nanocolumns with diameters ranging from 1.5 to 6 nm can be synthesized, this paper focuses on samples with larger nanocolumns, where the inner part of the columns are either disordered or amorphous.

The paper is organized as follows: in Sec. II we will present the experimental techniques used for the synthesis and the characterization [atomic force microscopy (AFM) and transmission electron microscopy (TEM) as well as x-ray scattering]; in Sec. III we will show, using elastic and atomistic simulations, how the GIXS maps can be interpreted in terms of strain and correlations of the GeMn nanocolumns and the surrounding Ge matrix.

II. EXPERIMENTS

A. Sample preparation

The (Ge,Mn) thin films were obtained using solid sources molecular-beam epitaxy on epi-ready Ge (001) wafers. First, a 40-nm-thick Ge buffer was grown at 250 °C after thermal desorption of the native oxide. Then Ge and Mn atoms were coevaporated in order to get a 60-80-nm-thick (Ge,Mn) layer with an overall Mn concentration ranging from ~6\% to ~10\%, depending on the relative ratio of the Mn and Ge evaporation flux. The growth temperature was set to ~100 °C and the growth rate was ~0.2 Å s$^{-1}$.

These growth parameters allow for a two-dimensional (2D) spinodal decomposition to take place at the early stages of the growth. Due to the layer-by-layer growth mode, the resulting (Ge,Mn) films are heterogeneous and made of columnar structures (nanocolumns) embedded in a matrix. In these conditions, nanocolumns have diameters ranging from 3 to 5 nm and densities between 10 000 and 20 000 μm$^{-2}$.

The chemical analysis in a transmission electron microscope has shown that the composition in the nanocolumns is close
Angular integration of the FFT as well as direct computation of the radial distribution function of the nanocolumns give an in-plane correlation distance between first neighbors of ~8 nm.

C. Atomic force microscopy

The surface of the samples was studied using AFM. The surface presents a root-mean-square roughness \( r_{\text{RMS}} \) =0.8 ± 0.3 nm, as measured over 500 x 500 nm\(^2\) areas [Fig. 1(c)]. A FFT analysis, shown in Fig. 1(d), similar to that performed on the plane-view TEM micrographs, exhibits a higher intensity ring at distances of about 40 nm, corresponding to a surface-roughness correlation length.

D. Grazing incidence x-ray scattering

In order to get a better understanding of the correlations between the nanocolumns and their effects on the strain in the matrix, we performed x-ray scattering measurements on beamlines ID01, BM32, and BM02 at the ESRF. We used energies around the Mn \( K \) edge (6.539 keV) and the Ge \( K \) edge (11.103 keV). In order to enhance the signal from the GeMn layer, we used a grazing incidence geometry with the incident angle tuned around the total reflection angle (\( \alpha_e =0.38^\circ \) at the Mn \( K \) edge and 0.19\(^\circ \) at the Ge \( K \) edge) in order to probe depths between 10 nm and 0.5 \( \mu m \).

The scattered intensity was measured using both grazing incidence small angle x-ray scattering (GISAXS) (Ref. 41) as well as wide angle geometry (close to Bragg reflections). GISAXS measurements are sensitive to the average shape and positional correlations between objects at or close to the surface, but in our case contrast in the average electronic density between the columns and the surrounding matrix is very low, which prevents the observation of the nanocolumn shape and distance correlation using this method.

However a GISAXS-type analysis could still be performed around Bragg reflections: as the detector used for wide-angle measurements was a Vantec position-sensitive one-dimensional detector oriented perpendicularly to the sample plane, we measured the intensity as a function of the exit angle. In the case of an angular scan around a (220) reflection, as shown in Fig. 2, the 2D data present features similar to classical GISAXS: the “enhanced contrast” is simply due to the sensitivity of GIXS near a Bragg reflection to any deformation (e.g., induced by the columns) in the layer.

Two peaks can be seen in the “Bragg-GISAXS” image: one (with \( d \approx 40 \text{ nm} \)) corresponding to the surface-roughness correlation [as shown in Fig. 1(d), and already reported by Holý \textit{et al.} \cite{22}] and another (with \( d \approx 8 \text{ nm} \)) corresponds to the average distance between neighboring columns, as shown in Fig. 1(b). Moreover, the latter peak exhibits fringes with a period corresponding to the thickness of the GeMn layer (60 nm), which is only possible because the columns are continuous over the whole thickness of the layer.\cite{82}

In the large in-plane grazing-incidence x-ray scattering maps, shown in Fig. 3(a), the most important feature is the absence of significant contributions far from the Bragg reflections of the standard diamond lattice. This is true for...
FIG. 2. (Color online) Bragg-GISAXS (see text for details) map measured by an angular scan around the in-plane (220) Bragg reflection, using a Vantec position-sensitive detector, at \( E=6.5 \) keV and \( \alpha_{g}=0.4^\circ \) (intensity plotted on a logarithmic scale, with eight contour levels per order of magnitude). \( Q_{\text{ang}} \) and \( Q_z \) are, respectively, parallel and perpendicular to the surface. Three finite distances effects can be seen, symmetrically about the \( Q_{\text{ang}}=0 \) axis: (i) a correlation distances of about 9–15 nm (marker “D”), corresponding to the average distance between columns, (ii) the oscillations (marker “T”) along \( Q_z \) (dotted-dashed line) are due to the finite thickness of the sample (60 nm), and (iii) the two intense streaks (marker “R”) at very small \( Q_{\text{ang}} \) have been attributed to the surface roughness.

samples which are the focus of this paper with nanocolumns featuring a large (\( \approx 4 \) nm) average diameter, and either a disordered or an amorphous inner structure.19

A weak diffuse streak is also visible between the (220) and (040) reflections with a faint diffuse (130) Bragg peak—these could either be due to diffuse scattering from the rough surface or be related to the inner structure of the nanocolumns (which is partially crystalline in the samples considered here)—this will not be the focus of this paper, which mostly deals with the strain of the surrounding matrix and the correlations between nanocolumns. We will now focus on these characteristics, which can be analyzed using the shape of the diffusion around the germanium Bragg peaks.

III. INTERPRETATION OF THE X-RAY SCATTERING
MAPS NEAR BRAGG REFLECTIONS

A specific diffusion is observed around all Bragg peaks, as can be seen in Figs. 3(b)–3(e): this type of scattering pattern is due to the deformation of the diamond lattice, since the nanocolumns have a larger average lattice parameter\(^{16,19} \) than that of bulk Ge. In Fig. 3 maps are shown for two different samples: Figs. 3(a)–3(e) correspond to the same sample with a strong asymmetry of the correlation ring, whereas Figs. 3(f) and 3(g) correspond to a similar sample measured after aging, and where the asymmetry is no longer present. This aging effect has already been observed quantitatively using superconducting quantum interference device (SQUID) magnetometry\(^{40} \) and has been linked to the sample oxidation. In the case of a very old sample (\( \approx 3 \) years in this case), it is expected that the columns are fully oxidized. Although no direct observation (using TEM) of the nanocolumns morphology has been made, the strong decrease in the asymmetry can be related to the relaxation of the matrix surrounding the nanocolumns, as we will now study.

In the case of GeMn nanocolumns it was shown\(^{16} \) that the surrounding matrix is compressed. Therefore a Huang-type diffusion\(^{43–45} \) could be expected—but however, the decrease in the intensity around a given reflection (i.e., when following the intensity in a radial direction from the center of the Bragg position) is not monotonous and features a maximum around a ring located at \( \Delta(H \text{ or } K)=0.07 \) reciprocal lattice units (r.l.u.), i.e., corresponding to a distance of \( \approx 8 \) nm in real space. This distance corresponds approximately to the average intercolumn distance, and therefore the location of the ring is due to the intercolumn distance correlation, while the polarization of this ring (the intensity is larger on the high-\( q \) side, and also larger along [100] and [010] directions) is due to the deformation field of the matrix, as we will now show using elastic and atomistic simulations.

A. Analytical model of the elastic deformations

The scattering from the GeMn layer can be calculated as the difference between the scattering of the distorted and perfect (i.e., without deformation or columns) lattices\(^{45} \)—the advantage of this method is that it avoids most oscillation fringes due to the finite size of the simulated lattice and also that it allows the superposition of the contributions from several insertions (columns in our case). The only approximation is that the sharp Bragg peak will not be obtained by this calculation.

With the further approximation that the columns have a similar size and scatter independently, the scattering is equal to the interference of the scattering of all the columns
where \( A(\vec{k}) \) is the scattering due to a single column and the associated distortion of the lattice, \( \vec{k} \) is the scattering vector, and \( \vec{R}_i \) is the position of column \( i \) in the sample. The intensity can then be written as

\[
I(\vec{k}) = |A(\vec{k})|^2 = |A_0(\vec{k})|^2 \sum_i e^{2\pi i \vec{k} \cdot \vec{R}_i} = |A_0(\vec{k})|^2 \times \sqrt{N + 2 \sum_{i<j} \cos 2\pi \vec{k} \cdot (\vec{R}_j - \vec{R}_i)}. \tag{2}
\]

With the above approximations the scattered intensity should be proportional to the scattering of a single nanocolumn, multiplied by an interference factor depending on the pair distribution of the columns. If we assume that the inner part of the column is not contributing to the scattering (either disordered or amorphous), then the scattering of the single column (again calculated as a difference with the scattering from a perfect infinite lattice) is the sum of the contribution from the displaced atoms in the Ge matrix and from the “hole” left in the Ge matrix by the column

\[
A_0(\vec{k}) = A(\text{displaced atoms}) + A(\text{hole})
\]

\[
= \sum_i f_i e^{2\pi i \vec{R}_i} \left( e^{2\pi i \vec{R}_i \cdot \vec{r}} - 1 \right) - \sum_j f_j e^{2\pi i \vec{k} \cdot \vec{r}_j}, \tag{3}
\]

where \( \vec{r}_i \) denotes the original position of atom \( i \) and \( \vec{u}_i \) its displacement.

The so-called Huang scattering\cite{43–45} typically yields nodal planes where the intensity is zero—which in this case would be expected for a plane perpendicular to the scattering vector. However this would only be true if only the \( A(\text{displaced atoms}) \) term was present—the contribution from the hole makes the nodal plane disappear.

We used the following analytical model\cite{46} for the radial displacements around a cylindrical nanocolumn:

\[
u(r > R) = \frac{\delta(1 + \nu)}{4\pi R^3(1 - \nu)}, \tag{4}
\]

where \( R \) is the column’s diameter, \( \delta \) is a parameter giving the extent of the deformation of the matrix, and \( \nu \) is the average Poisson coefficient for germanium. For the sake of simplicity we did not take into account the elastic anisotropy of germanium\cite{47} in this model.

In the next section, we use atomic positions generated by this model to compute the scattering around Bragg reflections.

**B. Calculated x-ray scattering from the analytical model**

Grazing incidence x-ray scattering was calculated using the atomic positions calculated from the elastic model: the displacements from an ideal germanium lattice are shown in Fig. 4(a). To take into account the pair distribution of columns, we measured the pair distribution using TEM plane view [Fig. 1(a)], and modeled it using an isotropic radial

![FIG. 3. (Color online) (a) Grazing-incidence RSM of the measured intensity in thehk0 plane—this map features almost only the (220) and (400) Ge Bragg peaks with a weak diffuse line between them. (b)–(e) High-resolution RSM around the (220), (400), (440), and (620) reflections. Around each Bragg peak an asymmetric ring can be seen at ≈0.07 r.l.u.: its positions is given by the average intercolumn distance while the asymmetry of the intensity is due to the compression of the matrix surrounding each column. In (f) and (g) are shown the RSM around reflections (220) and (400), for the same type of sample as for Fig. 2, but after oxidation (due to aging and exposure to air) of the sample: the correlation ring is almost circular due to the decrease in the strain of the Ge matrix around the oxidized columns. The intensity is represented as a logarithmic color scale, the full scale corresponding to 3 orders of magnitude for all plots.](#)
distribution function, as can be seen in Fig. 4(b). As the sample exhibits no structure above the surface (embedded nanocolumns), transmission coefficients\(^{48}\) for the incoming and outgoing x-ray beams at the surface were not taken into account, as they only affect the scattering as a constant scale factor; the intensity was therefore directly calculated using Eq. (2).

The results of the simulation around a (220) reflection are shown in Fig. 4(c) for a single isolated column and in Fig. 4(d) when taking into account pair correlations. In these simulations the intensity is larger at high Bragg angle, which is due to the compression of the Ge matrix by the nanocolumn. The pair correlation induces the correlation ring that is observed experimentally.

However the experimentally observed intensity still differs quantitatively from the simulated one, which is due to the ideal modeling of the lattice: (i) the columns are assumed to be identical [whereas the column diameter distribution is a Gaussian with an full width at half maximum (FWHM) of almost \(\approx 30\%\)], (ii) the radial distribution will also differ depending on the column size, (iii) the true deformation of the Ge matrix should take into account the elastic anisotropy of germanium,\(^{47}\) and (iv) the distance between columns (nearest-neighbor distance of \(\approx 8\) nm) is such that the displacement fields generated by all columns will not be independent. For this reason it is particularly interesting to perform atomistic simulations to obtain more realistic atomic positions taking into account intercolumn interactions, which is presented in the next section.

C. Atomistic simulations

In order to get a realistic elastic displacement field of the germanium matrix, atomistic simulations were conducted using a Stillinger-Weber potential\(^{49,50}\) for the atomic interactions—one advantage of this potential being that it was developed for both ordered and disordered condensed-matter phases. To simulate a collection of several columns, we used a domain consisting of \(100 \times 100\) Ge-diamond unit cells, while the size along the column axis was 4 unit cells. Periodic boundary conditions were used in the three space directions. The column density was chosen to be the experimental value, corresponding to an average of 42 columns per simulation cell (13 \(100\) \(\mu m^{-2}\)).

Starting from an empty simulation cell, the column’s centers were added successively at random positions but with an exclusion distance between each new column and the previous ones. This exclusion distance had a Gaussian distribution with a mean equal to 6.9 nm and a standard deviation equal to 0.35 nm. The resulting pair correlation has a peak at 7.6 nm close to the experimental value. The diameters of the columns were also set with a Gaussian distribution of mean and standard deviations, respectively, equal to 3.6 nm and 0.5 nm (corresponding to a FWHM of \(\approx 1.2\) nm). Ge atoms were set on the germanium-diamond lattice outside of the columns.

Because we are primarily interested in this paper by the matrix deformation and not by the precise structure of the GeMn columns themselves, we set atoms also interacting with the Stillinger-Weber potential, but at random positions inside the columns. Their initial density was the germanium density, but the lower density of the resulting amorphous structure leads to nanocolumns compressing the Ge matrix, as can be seen in Fig. 5.

A standard minimization of the total potential energy was then performed by conjugate gradient method. The resulting structure was a collection of amorphous nanocolumns embedded in a strained germanium lattice, as can be seen in Figs. 5 and 6(a).

To be able to simulate the \textit{incoherent} diffraction from
Weber potential, combining amorphous columns that could arise from the absolute configuration of the 100 unit cells, in order to average any “speckle” structure that could arise from the absolute configuration of the 42 GeMn nanocolumns in each simulation. The result of these simulations are shown in Figs. 6(b) and 6(c) for the (220) and (400) reflections, which compare well with the observed maps in Figs. 3(b) and 3(c).

The main difference with the results obtained using an elastic model (Sec. III A) is that there are fewer correlation rings (only the first order is now visible), which is both due to the distribution of columns diameters in the atomistic simulation as well as atomic displacements which correctly take into account the influence of neighboring columns.

In order to investigate the quantitative influence of the deformation of the Ge matrix on the asymmetry of the intensity in the correlation rings, we modified the simulated atomic positions by decreasing the displacement (with respect to an undistorted Ge lattice) of all atoms by a factor between 0 and 1. This approach is possible since atomic displacements are, in the elastic regime, proportional to the misfit introduced by the nanocolumns. The reciprocal space map (RSM) maps for a factor equal to 0.2 is shown in Figs. 6(d) and 6(e) and reproduce well the rings observed for the sample with the oxidized columns in Figs. 3(f) and 3(g).

A more quantitative comparison of the angular distribution of the intensity is presented in Fig. 7: the amplitude is maximum at ±45° with respect to the scattering vector, i.e., along the [100] and [010] directions around the (220) reflection, both in the simulation and in the experimental data. In Figs. 7(b), the angular distribution is shown as the amplitude of the atomic displacements (with respect to the perfect Ge lattice) is reduced from a maximum displacement of 0.05 nm down to no displacement: there is a clear reduc-
note that during this process, the diameter of the (oxidized) columns may have increased: but given the width of the size distribution of the nanocolumns (FWHM ≈ 1.2 nm), this would only moderately affect the scattered amplitude. Therefore, the decrease in the angular asymmetry of the intensity can directly be linked to the decrease in the strain in the Ge matrix.

IV. CONCLUSION AND SUMMARY

In this work we have shown that grazing incidence x-ray scattering maps can be used for a quantitative analysis of layers with GeMn nanocolumns embedded in germanium. In these samples the density of nanocolumns—related to the spinodal decomposition mechanism and the overall manganese concentration—leads to short (≈ 8 nm) correlation distances, which can directly be measured from x-ray scattering maps under the form of correlation rings around Bragg peaks of the germanium matrix. Moreover the angular-intensity distribution around these Bragg peaks shows a direct relation with the amplitude of the deformation in the matrix, which can range up to ≈ 0.05 nm and is found to decrease upon oxidation of the columns. A more systematic study of the effect of aging in GeMn nanocolumns (including transmission electronic measurements and SQUID magnetometry) is under way to fully understand the oxidation process and its effect on magnetic properties.

Finally, while this paper was focused on the study of the correlations between nanocolumns and the strain of the Ge matrix, several features indicate that there is a contribution for the inner part of the columns, such as the diffuse scattering between the (220) and (040) reflections as well as the weak, large scattering around the forbidden (130) reflection, as can be seen in Fig. 3. This aspect of the structure of GeMn layers will be developed in a separate article, notably considering possible atomic structures within the nanocolumns.39,51

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